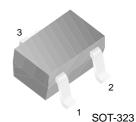


FJX3904 **NPN Epitaxial Silicon Transistor**

General Purpose Transistor



January 2007

1. Base 2. Emitter 3. Collector

Absolute Maximum Ratings* Ta=25°C unless otherwise noted

Symbol	Parameter	Value	Units	
V _{CBO}	Collector-Base Voltage	60	V	
V _{CES}	Collector-Emitter Voltage	40	V	
V _{EBO}	Emitter-Base Voltage	6	V	
I _C	Collector Current	200	mA	
P _C	Collector Power Dissipation	350	mW	
T _{STG}	Storage Temperature	-55 ~ 150	°C	

* These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

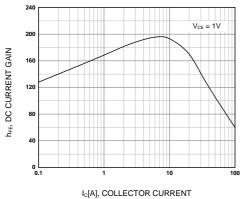
NOTES:

1) These ratings are based on a maximum junction temperature of 150°C.
2) These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.

Electrical Characteristics* T = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Max.	Units
BV _{CBO}	Collector-Base Breakdown Voltage	I _C =10μΑ, I _E =0	60		V
BV _{CEO}	* Collector-Emitter Breakdown Voltage	I _C =1mA, I _B =0	40		V
BV_{EBO}	Emitter-Base Breakdown Voltage	I _E =10μA, I _C =0	6		V
I _{CEX}	Collector Cut-off Current	V _{CE} =30V, V _{EB} =3V		50	nA
h _{FE}	* DC Current Gain		40 70 100 60 30	300	
V _{CE} (sat)	* Collector-Emitter Saturation Voltage	I _C =10mA, I _B =1mA I _C =50mA, I _B =5mA		0.2 0.3	V V
V _{BE} (sat)	* Base-Emitter Saturation Voltage	I _C =10mA, I _B =1mA I _C =50mA, I _B =5mA	0.65	0.85 0.95	V V
C _{ob}	Output Capacitance	V _{CB} =5V, I _E =0, f=1MHz		4	pF
f _T	Current Gain Bandwidth Product	V _{CE} =20V, I _C =10mA	300		MHz
NF	Noise Figure	I _C =100 μ A, V _{CE} =5V, R _S =1K Ω f=10Hz to 15.7KHz		5	dB
t _{ON}	Turn On Time	V _{CC} =3V, V _{BE} =0.5V I _C =10mA, I _{B1} =1mA		70	ns
t _{OFF}	Turn Off Time	$V_{CC}=3V$, $I_{C}=10$ mA $I_{B1}=I_{B2}=1$ mA		250	ns

Device Item (note) **Device Marking** Package **Packing Method** Qty(pcs) FJX3904TF SOT-323 TAPE & REEL 3,000 S1A Note : The Suffix "-TF" means Tape& Reel packing method, which can be on fairchildsemi website at http://www.fairchildsemi.com/packaging **Typical Performance Characteristics**



Package Marking and Ordering Information

Figure 1. DC current Gain

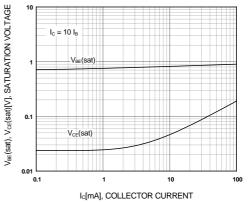


Figure 2. Base-Emitter Saturation Voltage Collector-Emitter Saturation Voltage

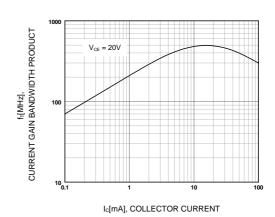
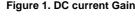
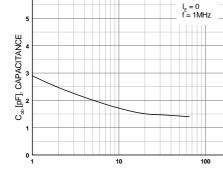


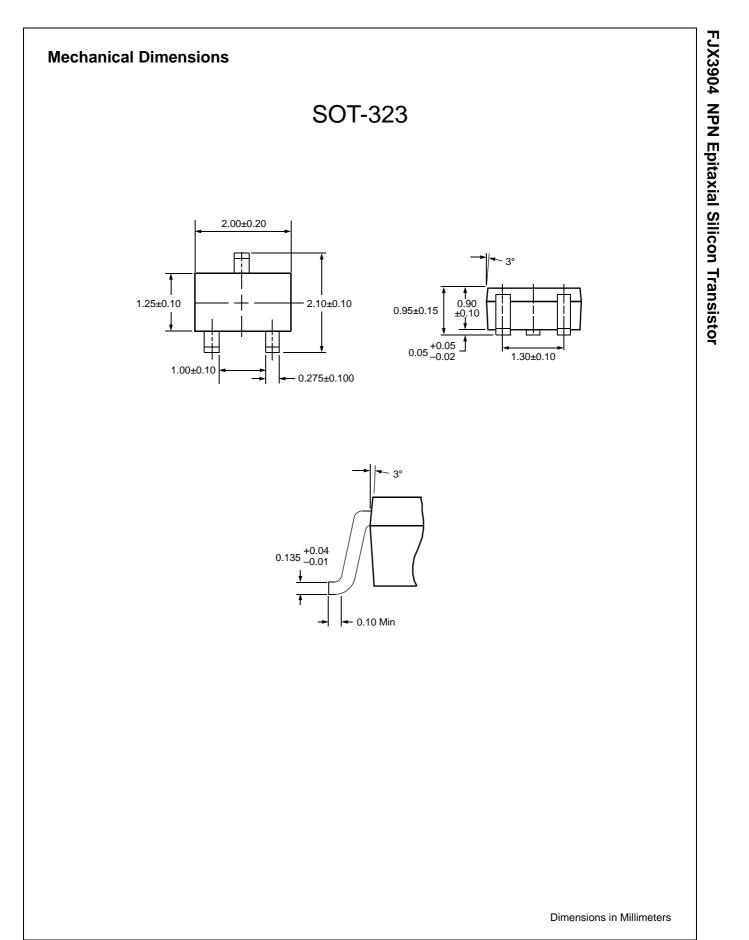
Figure 4. Current Gain Bandwidth Product





V_{CB} [V], COLLECTOR-BASE VOLTAGE

Figure 3. Output Capacitance





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